

MOS FIELD EFFECT TRANSISTOR 2SK3061

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3061 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3061	Isolated TO-220

FEATURES

· Low on-state resistance

RDS(on)1 = $8.5 \text{ m}\Omega$ MAX. (Vgs = 10 V, ID = 35 A)

 $R_{DS(on)2}$ = 12 $m\Omega$ MAX. (Vgs = 4.0 V, ID = 35 A)

- Low Ciss: Ciss = 5200 pF TYP.
- Built-in gate protection diode
- Isolated TO-220 package

(Isolated TO-220)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vss = 0 V)	Voss	60	V
Gate to Source Voltage (VDS = 0 V)	VGSS(AC)	±20	V
Gate to Source Voltage (VDS = 0 V)	VGSS(DC)	+20, -10	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±70	Α
Drain Current (pulse) Note1	ID(pulse)	±280	Α
Total Power Dissipation (Tc = 25°C)	P _{T1}	35	W
Total Power Dissipation (T _A = 25°C)	P _{T2}	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	35	Α
Single Avalanche Energy Note2	Eas	122.5	mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting T_{ch} = 25 °C, V_{DD} = 30 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

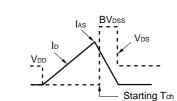


ELECTRICAL CHARACTERISTICS (TA = 25°C)

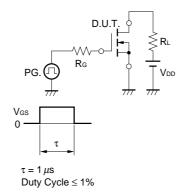
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	Vps = 60 V, Vgs = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.5	2.0	٧
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 35 A	20	87		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 35 A		6.3	8.5	mΩ
	RDS(on)2	Vgs = 4.0 V, ID = 35 A		8.2	12	mΩ
Input Capacitance	Ciss	Vps = 10 V		5200		pF
Output Capacitance	Coss	Vgs = 0 V		1300		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		480		pF
Turn-on Delay Time	t d(on)	ID = 35 A		75		ns
Rise Time	tr	Vgs = 10 V		1150		ns
Turn-off Delay Time	t _{d(off)}	VDD = 30 V		360		ns
Fall Time	tf	$R_G = 10 \Omega$		480		ns
Total Gate Charge	Q G	ID = 70 A		95		nC
Gate to Source Charge	Qgs	V _{DD} = 48 V		13		nC
Gate to Drain Charge	Q _{GD}	Vss = 10 V		30		nC
Body Diode Forward Voltage	V _F (S-D)	IF = 70 A, VGS = 0 V		0.97		V
Reverse Recovery Time	trr	IF = 70 A, VGS = 0 V		70		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		140		nC

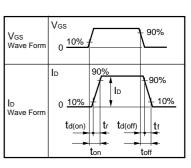
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c|c} \text{D.U.T.} \\ \text{RG} = 25 \ \Omega \\ \text{PG.} \\ \hline \\ \text{V}_{\text{GS}} = 20 \rightarrow 0 \ \text{V} \end{array}$

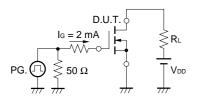


TEST CIRCUIT 2 SWITCHING TIME



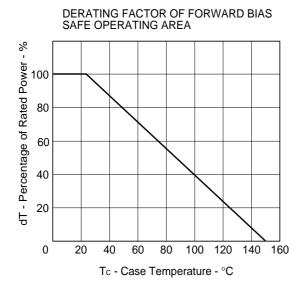


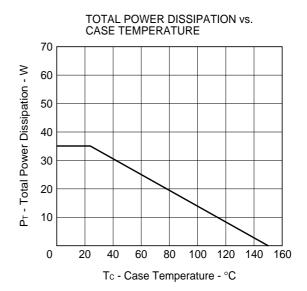
TEST CIRCUIT 3 GATE CHARGE



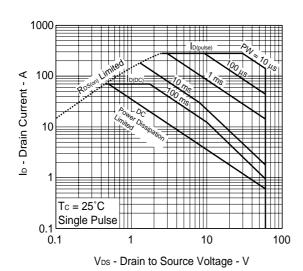


TYPICAL CHARACTERISTICS (TA = 25°C)

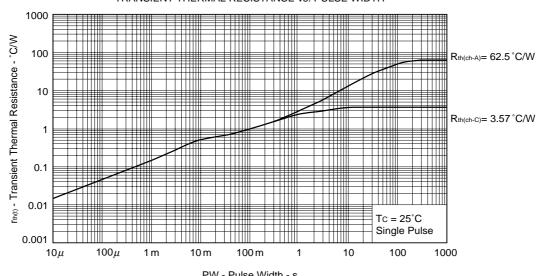




FORWARD BIAS SAFE OPERATING AREA



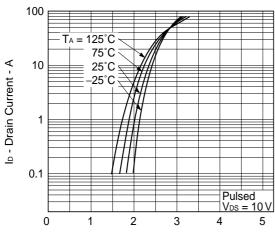
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



PW - Pulse Width - s

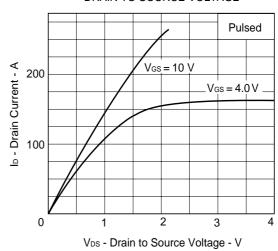
Data Sheet D13100EJ2V0DS

FORWARD TRANSFER CHARACTERISTICS

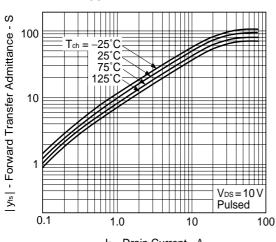


Vgs - Gate to Source Voltage - V

DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

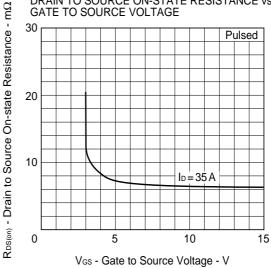


FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

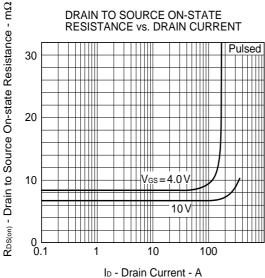


ID - Drain Current - A

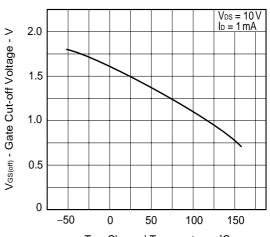
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



DRAIN TO SOURCE ON-STATE

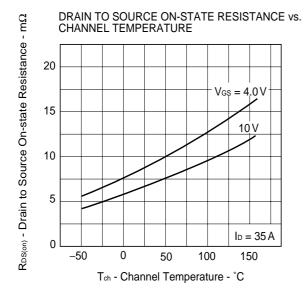


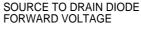
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

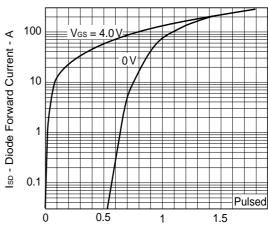


 T_{ch} - Channel Temperature - $^{\circ}C$



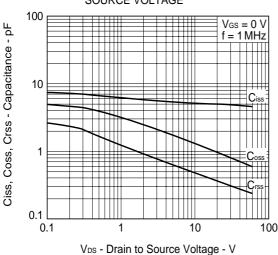




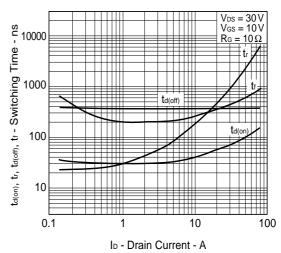


VsD - Source to Drain Voltage - V

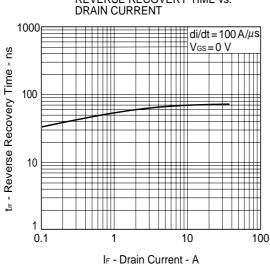
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



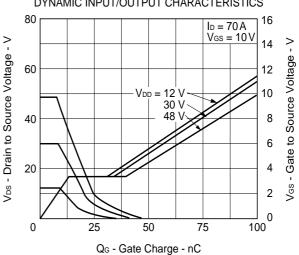
SWITCHING CHARACTERISTICS



REVERSE RECOVERY TIME vs.

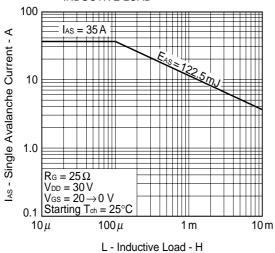


DYNAMIC INPUT/OUTPUT CHARACTERISTICS

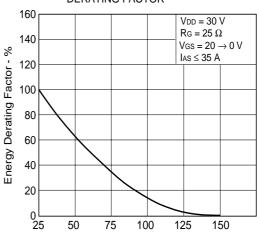


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SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY DERATING FACTOR

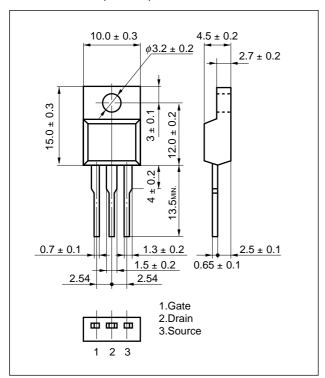


Starting T_{ch} - Starting Channel Temperature - $^{\circ}C$

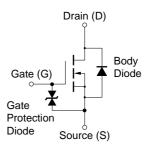


PACKAGE DRAWING (Unit: mm)

Isolated TO-220 (MP-45F)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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